



Imaging

DECOMPOSITION OF E-WAVE DECELERATION TIME INTO STIFFNESS AND RELAXATION COMPONENTS

Poster Contributions

Poster Sessions, Expo North

Saturday, March 09, 2013, 10:00 a.m.-10:45 a.m.

Session Title: Imaging: LV Diastolic Function

Abstract Category: 18. Imaging: Echo

Presentation Number: 1143-357

Authors: Sina Mossahebi, Sandor Kovacs, Washington University in St. Louis, St. Louis, MO, USA

Background: The short deceleration time (DT) ("constrictive-restrictive") E-wave pattern is due to increased chamber stiffness, while prolonged E-wave deceleration time is due to 'delayed relaxation'. Therefore, stiffness and relaxation are DT determinants. DT has been expressed algebraically as a function of stiffness only. Subsequent analysis of E-waves via the parametrized diastolic filling (PDF) formalism revealed that DT is an algebraic function of both stiffness and relaxation.

Method: We hypothesize that E-wave analysis via PDF permits decomposition of DT into stiffness (DT_s) and relaxation (DT_r) components (DT = DT_s + DT_r), reflecting diastatic chamber stiffness (K, slope of diastatic pressure-volume relation), and relaxation (τ, isovolumic time-constant) effects. For validation, simultaneous (conductance catheter) pressure-volume (P-V) and E-wave data from 12 control subjects, normal (>50%) LV ejection fraction, and 4 with delayed relaxation (DT>220 msec) were analyzed. PDF analysis of each E-wave provided DT_s and DT_r.

Results: For all 16 subjects (27 beats/subject, 430 beats total) linear regression yielded DT_s = α K + β (R² = 0.72) where α = -0.37 and β = 0.19, and DT_r = m τ + b (R² = 0.89) where m = 2.49 and b = -0.10.

Conclusion: E-wave DT consists of stiffness (DT_s) and relaxation (DT_r) components that are determined by diastatic chamber stiffness (K) and relaxation (τ) respectively.

